

# XG5007HS GaN TRANSISTOR

Document Number: XG5007HS  
Preliminary Datasheet V1.0

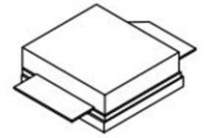
## Gallium Nitride 28V 70W, 1-5GHz RF Power Transistor

### Description

The XG5007HS itself is a 70W 28V GaN HEMT, implemented with patented match topology at both input and output side, enable extremely wideband applications with frequencies from 1 to 6GHz. **In typical full band operation, it can deliver >40W. When operated at higher voltage like 32V, it can deliver 50W across the full band.**

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

**XG5007HS**



- Typical CW performance (on Innogration wide band fixture with device soldered)

XG5007HS <sup>V0</sup> VGS=-2.25V VDS=28V IDQ=190mA CW								
Freq (MHz)	Psat (dBm)	Psat (W)	IDS (A)	Pin (dBm)	Gain (dB)	Eff(%)	2nd (dBc)	3rd (dBc)
700	44.43	27.7	1.41	37.40	7.03	70.25	-10.50	-14.10
800	45.36	34.4	1.76	37.80	7.56	69.72	-13.50	-14.40
1000	46.30	42.7	2.28	38.00	8.30	66.82	-15.40	-12.50
1500	46.46	44.3	2.71	38.16	8.30	58.33	-12.00	-12.80
2000	46.60	45.7	3.37	38.40	8.20	48.44	-16.00	-20.60
2500	47.78	60.0	4.70	39.60	8.18	45.58	-14.50	-22.60
3000	47.60	57.5	4.33	39.10	8.50	47.46	-27.40	-29.40
3500	46.86	48.5	4.12	39.43	7.43	42.07	/	/
4000	46.73	47.1	4.76	39.35	7.38	35.34	/	/
4500	46.89	48.9	5.27	39.35	7.54	33.12	/	/
5000	46.54	45.1	4.10	39.00	7.54	39.27	/	/

\*32V data upon request

### Applications and Features

- Suitable for wireless communication infrastructure, wideband amplifier, EMC testing, ISM etc.
- High Efficiency and Linear Gain Operations
- Thermally Enhanced Industry Standard Package
- High Reliability Metallization Process
- Excellent thermal Stability and Excellent Ruggedness
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

### Important Note: Proper Biasing Sequence for GaN HEMT Transistors

#### Turning the device ON

1. Set VGS to the pinch-off (VP) voltage, typically -5 V
2. Turn on VDS to nominal supply voltage (28V)
3. Increase VGS until IDS current is attained
4. Apply RF input power to desired level

#### Turning the device OFF

1. Turn RF power off
2. Reduce VGS down to VP, typically -5 V
3. Reduce VDS down to 0 V
4. Turn off VGS

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**Table 1. Maximum Ratings (Not simultaneous, TC = 25°C unless otherwise noted)**

Rating	Symbol	Value	Unit
Drain--Source Voltage	$V_{DS}$	150	Vdc
Gate--Source Voltage	$V_{GS}$	-10,+2	Vdc
Operating Voltage	$V_{DD}$	32	Vdc
Maximum Forward Gate Current	$I_{gmax}$	16.8	mA
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_c$	+150	°C
Operating Junction Temperature(See note 1)	$T_j$	+225	°C

1. Continuous operation at maximum junction temperature will affect MTTF

**Table 2. Thermal Characteristics**

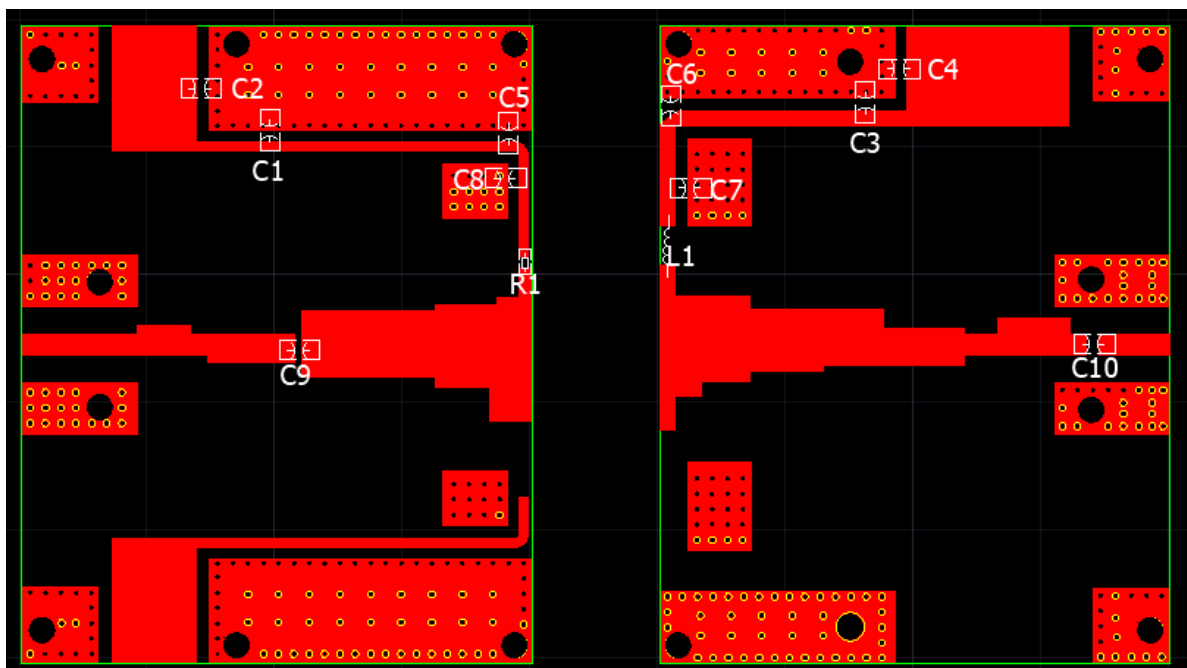
Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case $T_c=85^\circ\text{C}, T_j=200^\circ\text{C}, \text{FEA}$	$R_{\theta JC-DC}$	2.3	°C/W

**Table 3. Electrical Characteristics ( $T_c = 25^\circ\text{C}$  unless otherwise noted)**

### DC Characteristics

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS}=-8\text{V}; I_{DS}=16.8\text{mA}$	$V_{DSS}$	150			V
Gate Threshold Voltage	$V_{DS}=28\text{V}, I_D=16.8\text{mA}$	$V_{GS(th)}$		-2.7		V
Gate Quiescent Voltage	$V_{DS}=28\text{V}, I_{DS}=190\text{mA}$ , Measured in Functional Test	$V_{GS(Q)}$		-2.25		V

### Reference Circuit of Test Fixture Assembly Diagram



**Figure 1. Test Circuit Component Layout (1-5GHz)**

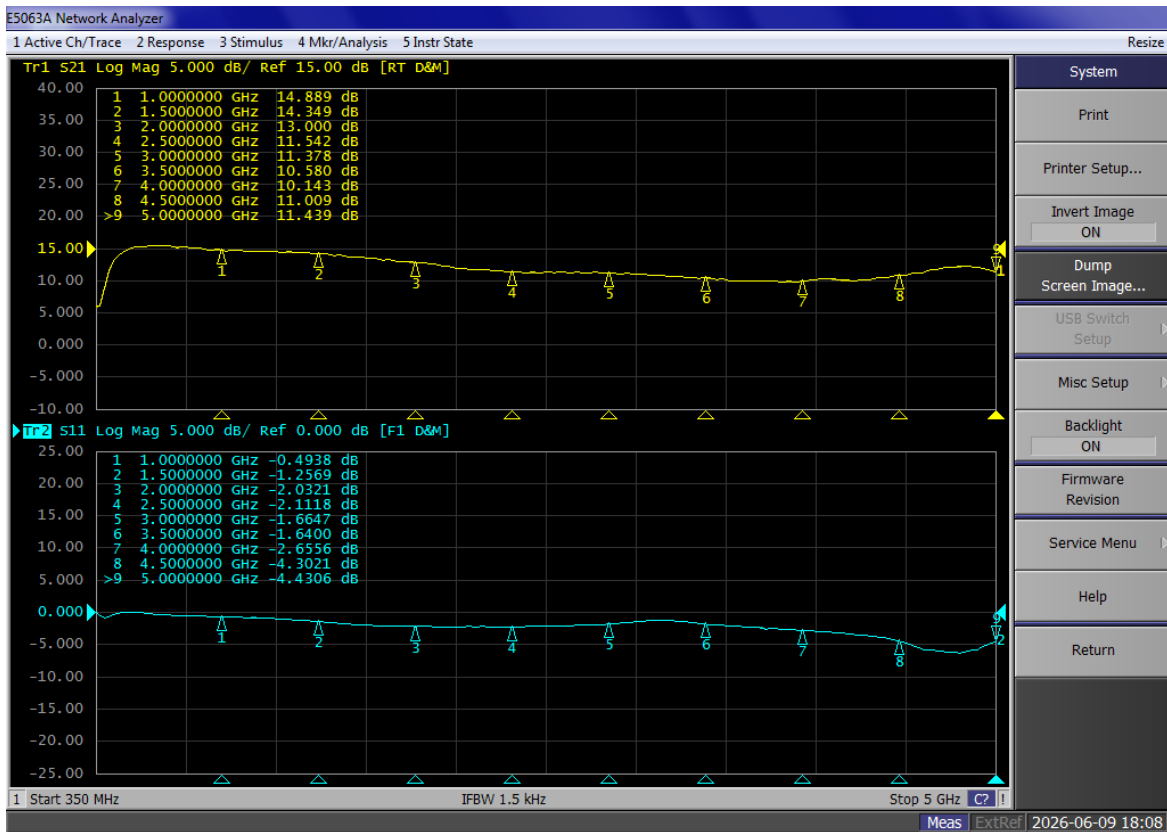
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Table 4. Test Circuit Component Designations and Values

Component	Description	Suggested Manufacturer
C1~C4	10uF/200V-1210	Ceramic multilayer capacitor
C5~C7	10nF/200V-1210	Ceramic multilayer capacitor
C8	100pF	
C9	8.2pF	
C10	5.6pF	ATC600S
R1	10 $\Omega$ -1206	Chip Resistor
L1	1mm wire , 3mm inner diameter, 1Turns	DIY
PCB	Rogers4350B 30mil	

Figure 2. Network Analyzer S11/S21 output (Vgs=-2.25V, Vds=28V, Idq=190mA)

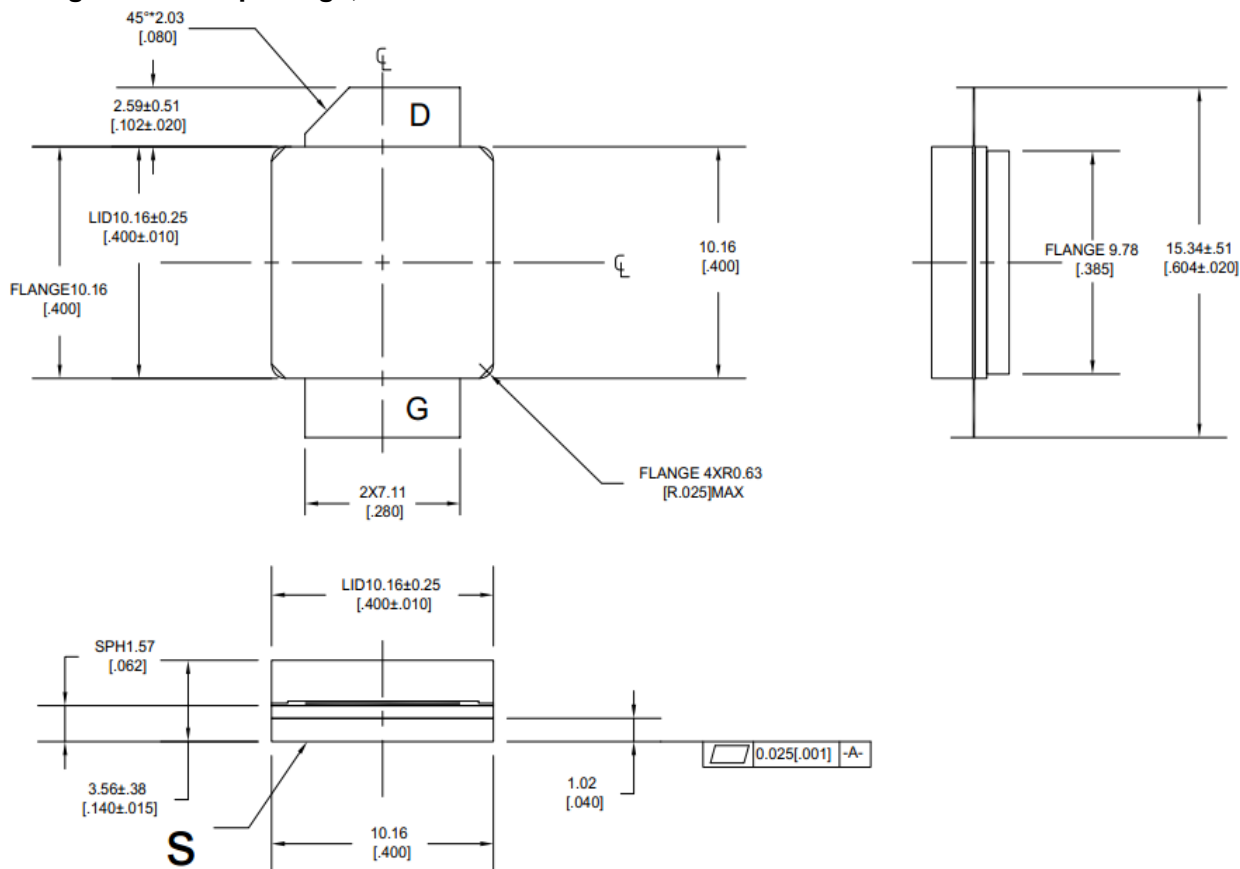


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## Package Outline

Flanged ceramic package; 2 leads



Unit: mm [inch]

Tolerance .xx +/- 0.01 .xxx +/- 0.005 inches

## Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2026/6/10	V1.0	Preliminary datasheet creation

Application data based on TC-26-21

## Notice

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